

Notic of Ref rences Cited

Application/Control No.

10/045,017

Applicant(s)/Patent Under
Reexamination
TERAO ET AL.

Examiner

Peter J Macchiarolo

Art Unit

2875

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,456,007	09-2002	Ryu et al.	313/586
	B	US-6,307,318	10-2001	Kaake et al.	313/586
	C	US-6,236,160	05-2001	Komaki et al.	313/586
	D	US-5,384,514	01-1995	Kim, Dae-il	313/585
	E	US-5,041,759	08-1991	Kwon et al.	313/495
	F	US-4,423,352	12-1983	Miyazaki et al.	313/584
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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